

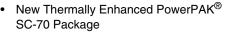
N-Channel 20-V (D-S) MOSFET with Trench Schottky Diode

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
	0.053 at V _{GS} = 4.5 V	4.5				
20	0.063 at V _{GS} = 2.5 V	4.5	4.1 nC			
	0.077 at V _{GS} = 1.8 V	4.5				

SCHOTT	SCHOTTKY PRODUCT SUMMARY					
V _{KA} (V)	V _f (V) Diode Forward Voltage	I _F (A) ^a				
20	0.45 at 1 A	2				

FEATURES

- · Halogen-free
- LITTLE FOOT® Plus Schottky Power MOSFET

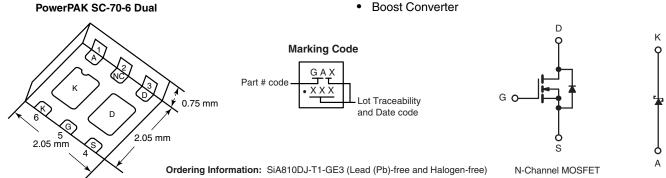




- Small Footprint Area
- Low On-Resistance
- Thin 0.75 mm profile
- Low V_f Trench Schottky Diode

APPLICATIONS

- Load Switch for Portable Devices (MP3/Cellular)
- Boost Converter



Parameter	Symbol	Limit	Unit		
Drain-Source Voltage (MOSFET)		V _{DS}	20		
Reverse Voltage (Schottky)		V _{KA}	20	V	
Gate-Source Voltage (MOSFET)		V _{GS}	± 8		
	T _C = 25 °C		4.5 ^a		
Continuous Drain Current /T = 150 °C\ (MOSEET)	T _C = 70 °C		4.5 ^a		
Continuous Drain Current (T _J = 150 °C) (MOSFET)	T _A = 25 °C	I _D	4.5 ^{a, b, c}		
	T _A = 70 °C		3.8 ^{b, c}		
Pulsed Drain Current (MOSFET)		I _{DM}	20	A	
Continuous Source-Drain Diode Current	T _C = 25 °C T _A = 25 °C		4.5 ^a		
(MOSFET Diode Conduction)		I _S	1.6 ^{b, c}		
Average Forward Current (Schottky)		I _F	2 ^b	7	
Pulsed Forward Current (Schottky)	I _{FM}	5			
	T _C = 25 °C		6.5		
Maximum Daylor Dissipation (MOCFFT)	T _C = 70 °C		5	w	
Maximum Power Dissipation (MOSFET)	T _A = 25 °C		1.9 ^{b, c}		
	T _A = 70 °C	P _D	1.2 ^{b, c}		
	T _C = 25 °C	' b	6.8		
Maximum Bower Dissipation (Schottler)	T _C = 70 °C		4.3		
Maximum Power Dissipation (Schottky)	T _A = 25 °C		1.6 ^{b, c}		
	T _A = 70 °C		1.0 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature) ^{d, e}		260			

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THERMAL RESISTANCE RATINGS								
Parameter		Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient (MOSFET) ^{b, f}	t ≤ 5 s	R _{thJA}	52	65				
Maximum Junction-to-Case (Drain) (MOSFET)	Steady State	R _{thJC}	12.5	16	°C/W			
Maximum Junction-to-Ambient (Schottky) ^{b, g}	t ≤ 5 s	R _{thJA}	62	76	C/VV			
Maximum Junction-to-Case (Drain) (Schottky)	Steady State	R _{thJC}	15	18.5				

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See Solder Profile (http://www.vishay.com/ppg?73257). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

 f. Maximum under Steady State conditions is 110 °C/W.

 g. Maximum under Steady State conditions is 110 °C/W.

SPECIFICATIONS $T_J = 25^{\circ}$	C, unless othe	erwise noted				
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		1		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 – 230 μΑ		- 2.8		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.4		1	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	1	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	
	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	20			Α
Drain-Source On-State Resistance ^a		$V_{GS} = 4.5 \text{ V}, I_D = 3.7 \text{ A}$		0.043	0.053	
	R _{DS(on)}	$V_{GS} = 2.5 \text{ V}, I_D = 3.4 \text{ A}$		0.052	0.063	Ω
		$V_{GS} = 1.8 \text{ V}, I_D = 1.1 \text{ A}$		0.062	0.077	
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 10 \text{ V}, I_{D} = 3.7 \text{ A}$		15		S
Dynamic ^b						
Input Capacitance	C _{iss}			400		
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		70		pF
Reverse Transfer Capacitance	C _{rss}			40		
Total Cata Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 8 \text{ V}, I_D = 4.8 \text{ A}$		7	11.5	nC
Total Gate Charge	Q_g			4.1	7	
Gate-Source Charge	Q_{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 4.8 \text{ A}$		0.65		
Gate-Drain Charge	Q _{gd}			0.8		
Gate Resistance	R_{g}	f = 1 MHz		2.5		Ω
Turn-On Delay Time	t _{d(on)}			5	10	
Rise Time	t _r	V_{DD} = 10 V, R_L = 2.6 Ω		32	50	
Turn-Off DelayTime	t _{d(off)}	$I_D\cong 3.8$ A, $V_{GEN}=4.5$ V, $R_g=1$ Ω		30	45	
Fall Time	t _f	•		53	80	
Turn-On Delay Time	t _{d(on)}			5	10	ns
Rise Time	t _r	V_{DD} = 10 V, R_L = 2.6 Ω		12	20	
Turn-Off DelayTime	t _{d(off)}	$I_D\cong~3.8~A,~V_{GEN}=8~V,~R_g=1~\Omega$		15	25	
Fall Time	t _f	-		10	15	



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SPECIFICATIONS T _J = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			4.5	Α		
Pulse Diode Forward Current	I _{SM}				20			
Body Diode Voltage	V_{SD}	$I_S = 3.8 \text{ A}, V_{GS} = 0 \text{ V}$		0.8	1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 3.8 A, di/dt = 100 A/μs, T _{.I} = 25 °C		8.5	20	nC		
Reverse Recovery Fall Time	t _a	- 1; - 0.0 Λ, αναι - 100 Λ/μ3, 1 j - 23 0		10		ns		
Reverse Recovery Rise Time	t _b			5		115		

Notes:

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

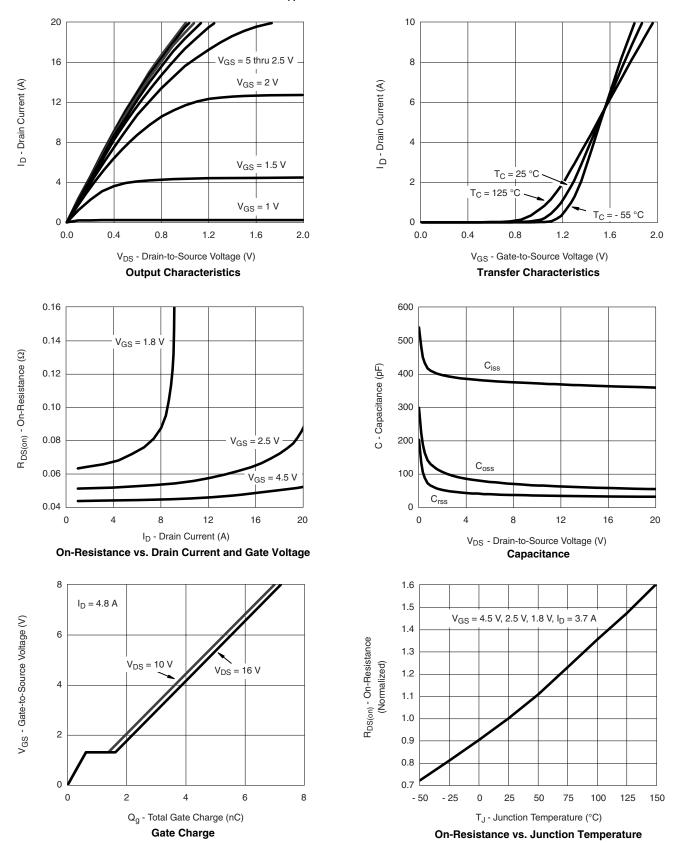
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Forward Voltage Drop	V _F	I _F = 1 A		0.41	0.45	V
	VF.	I _F = 1 A, T _J = 125 °C		0.36	0.41	
Maximum Reverse Leakage Current		V _r = 5 V		0.015	0.08	-
		V _r = 5 V, T _J = 85 °C		0.50	5.00	
	I _{rm}	V _r = 20 V		0.02	0.10	mA
		$V_r = 20 \text{ V}, T_J = 85 ^{\circ}\text{C}$		0.7	7	1
		V _r = 20 V, T _J = 125 °C		5	50	
Junction Capacitance	C _T	V _r = 10 V		60		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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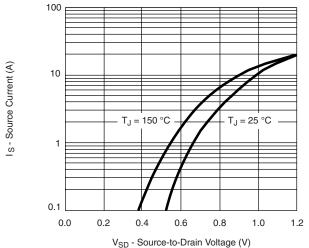


MOSFET TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted

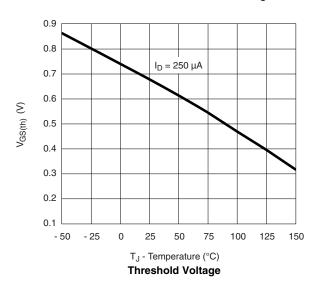


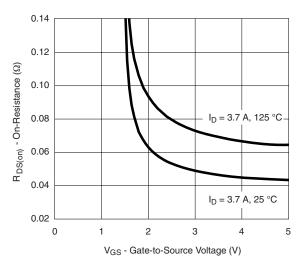


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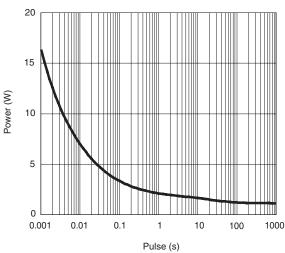


Source-Drain Diode Forward Voltage

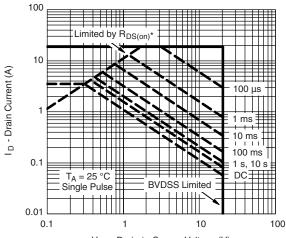




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power (Junction-to-Ambient)



 $\label{eq:VDS} V_{DS} \text{ - Drain-to-Source Voltage (V)} \\ ^*V_{GS} > \text{minimum } V_{GS} \text{ at which } R_{DS(on)} \text{ is specified}$

Safe Operating Area, Junction-to-Ambient

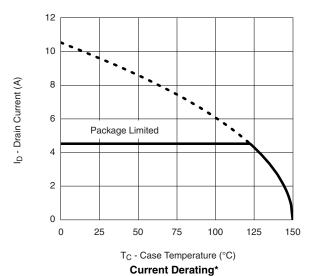
Power Dissipation (W)

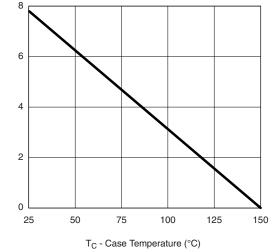
SiA810DJ

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MOSFET TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



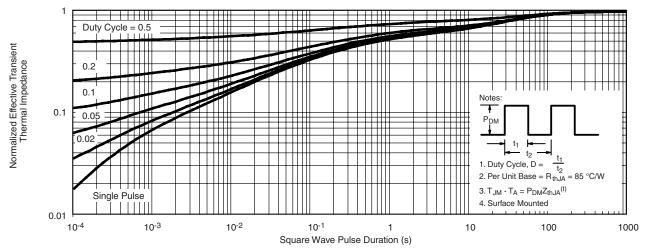


Power Derating

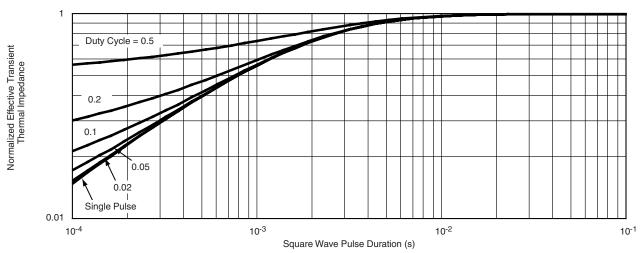
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



MOSFET TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

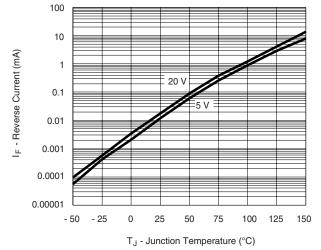


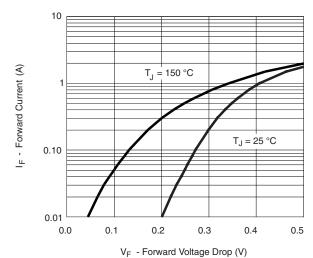
Normalized Thermal Transient Impedance, Junction-to-Case

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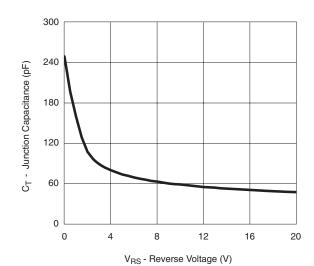
SCHOTTKY TYPICAL CHARACTERISTICS $T_A = 25~^{\circ}C$, unless otherwise noted





Reverse Current vs. Junction Temperature

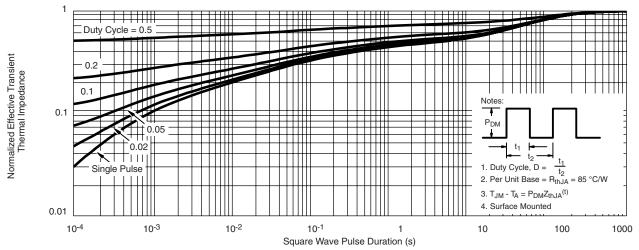
Forward Voltage Drop



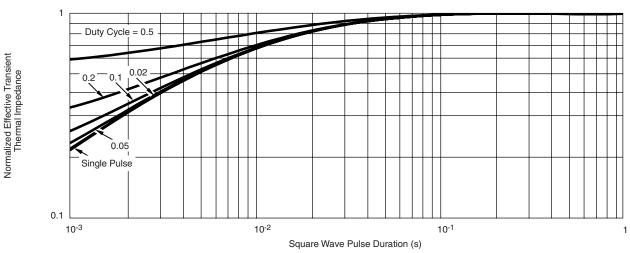
Capacitance



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Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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